

IMPORTANT NOTICE

USAGE OF THE DAE4

The DAE unit is a delicate, high precision instrument and requires careful treatment by the user. There are no serviceable parts inside the DAE. Special attention shall be given to the following points:

Battery Exchange: The battery cover of the DAE4 unit is closed using a screw, over tightening the screw may cause the threads inside the DAE to wear out.

Shipping of the DAE: Before shipping the DAE to SPEAG for calibration, remove the batteries and pack the DAE in an antistatic bag. This antistatic bag shall then be packed into a larger box or container which protects the DAE from impacts during transportation. The package shall be marked to indicate that a fragile instrument is inside.

E-Stop Failures: Touch detection may be malfunctioning due to broken magnets in the E-stop. Rough handling of the E-stop may lead to damage of these magnets. Touch and collision errors are often caused by dust and dirt accumulated in the E-stop. To prevent E-stop failure, the customer shall always mount the probe to the DAE carefully and keep the DAE unit in a non-dusty environment if not used for measurements.

Repair: Minor repairs are performed at no extra cost during the calibration. However, SPEAG reserves the right to charge for any repair especially if rough unprofessional handling caused the defect.

DASY Configuration Files: Since the exact values of the DAE input resistances, as measured during the calibration procedure of a DAE unit, are not used by the DASY software, a nominal value of 200 MOhm is given in the corresponding configuration file.

Important Note:

Warranty and calibration is void if the DAE unit is disassembled partly or fully by the Customer.

Important Note:

Never attempt to grease or oil the E-stop assembly. Cleaning and readjusting of the E-stop assembly is allowed by certified SPEAG personnel only and is part of the calibration procedure.

Important Note:

To prevent damage of the DAE probe connector pins, use great care when installing the probe to the DAE. Carefully connect the probe with the connector notch oriented in the mating position. Avoid any rotational movement of the probe body versus the DAE while turning the locking nut of the connector. The same care shall be used when disconnecting the probe from the DAE.



Accredited by the Swiss Accreditation Service (SAS)
The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: SCS 0108

Client **BTL Inc.**
Guangdong

Certificate No: DAE4-420_Mar24/2

CALIBRATION CERTIFICATE (Replacement of No: DAE4-420_Mar24)

Object DAE4 - SD 000 D04 BN - SN: 420

Calibration procedure(s) QA CAL-06.v30
Calibration procedure for the data acquisition electronics (DAE)

Calibration date: March 19, 2024

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature $(22 \pm 3)^{\circ}\text{C}$ and humidity $< 70\%$.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Keithley Multimeter Type 2001	SN: 0810278	29-Aug-23 (No:37421)	Aug-24
Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Auto DAE Calibration Unit	SE UWS 053 AA 1001	23-Jan-24 (in house check)	In house check: Jan-25
Calibrator Box V2.1	SE UMS 006 AA 1002	23-Jan-24 (in house check)	In house check: Jan-25

Calibrated by:	Name	Function	Signature
	Adrian Gehring	Laboratory Technician	
Approved by:	Name	Function	Signature
	Sven Kühn	Technical Manager	

Issued: May 21, 2024

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Accredited by the Swiss Accreditation Service (SAS)

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Multilateral Agreement for the recognition of calibration certificates

Glossary

DAE data acquisition electronics
Connector angle information used in DASY system to align probe sensor X to the robot coordinate system.

Methods Applied and Interpretation of Parameters

- **DC Voltage Measurement:** Calibration Factor assessed for use in DASY system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.
- **Connector angle:** The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
- The following parameters as documented in the Appendix contain technical information as a result from the performance test and require no uncertainty.
 - **DC Voltage Measurement Linearity:** Verification of the Linearity at +10% and -10% of the nominal calibration voltage. Influence of offset voltage is included in this measurement.
 - **Common mode sensitivity:** Influence of a positive or negative common mode voltage on the differential measurement.
 - **Channel separation:** Influence of a voltage on the neighbor channels not subject to an input voltage.
 - **AD Converter Values with inputs shorted:** Values on the internal AD converter corresponding to zero input voltage
 - **Input Offset Measurement:** Output voltage and statistical results over a large number of zero voltage measurements.
 - **Input Offset Current:** Typical value for information; Maximum channel input offset current, not considering the input resistance.
 - **Input resistance:** Typical value for information: DAE input resistance at the connector, during internal auto-zeroing and during measurement.
 - **Low Battery Alarm Voltage:** Typical value for information. Below this voltage, a battery alarm signal is generated.
 - **Power consumption:** Typical value for information. Supply currents in various operating modes.

DC Voltage Measurement

A/D - Converter Resolution nominal

High Range: 1LSB = 6.1 μ V , full range = -100...+300 mV

Low Range: 1LSB = 61nV , full range = -1.....+3mV

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Calibration Factors	X	Y	Z
High Range	405.558 $\pm$ 0.02% (k=2)	405.128 $\pm$ 0.02% (k=2)	406.185 $\pm$ 0.02% (k=2)
Low Range	3.91375 $\pm$ 1.50% (k=2)	3.99564 $\pm$ 1.50% (k=2)	3.97531 $\pm$ 1.50% (k=2)

Connector Angle

Connector Angle to be used in DASY system	139.5 ° $\pm$ 1 °
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Appendix (Additional assessments outside the scope of SCS0108)

1. DC Voltage Linearity

High Range	Reading (μV)	Difference (μV)	Error (%)
Channel X + Input	200017.30	-0.90	-0.00
Channel X + Input	19991.37	2.63	0.01
Channel X - Input	-20026.19	-2.53	0.01
Channel Y + Input	200016.95	-4.75	-0.00
Channel Y + Input	19991.14	2.11	0.01
Channel Y - Input	-20027.19	-3.86	0.02
Channel Z + Input	200018.31	0.05	0.00
Channel Z + Input	19990.77	1.57	0.01
Channel Z - Input	-20025.65	-2.27	0.01

Low Range	Reading (μV)	Difference (μV)	Error (%)
Channel X + Input	1982.98	-0.79	-0.04
Channel X + Input	182.90	-0.83	-0.45
Channel X - Input	-217.67	-1.50	0.70
Channel Y + Input	1983.95	-0.18	-0.01
Channel Y + Input	182.82	-1.28	-0.70
Channel Y - Input	-217.71	-1.81	0.84
Channel Z + Input	1984.17	0.01	0.00
Channel Z + Input	183.06	-0.98	-0.53
Channel Z - Input	-217.68	-1.80	0.83

2. Common mode sensitivity

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Common mode Input Voltage (mV)	High Range Average Reading (μV)	Low Range Average Reading (μV)
Channel X	200	-10.36	-11.44
	- 200	11.61	10.26
Channel Y	200	9.57	8.63
	- 200	-11.70	-11.51
Channel Z	200	22.31	22.49
	- 200	-25.23	-25.05

3. Channel separation

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Input Voltage (mV)	Channel X (μV)	Channel Y (μV)	Channel Z (μV)
Channel X	200	-	0.58	-1.56
Channel Y	200	5.25	-	2.73
Channel Z	200	4.90	3.82	-

4. AD-Converter Values with inputs shorted

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	High Range (LSB)	Low Range (LSB)
Channel X	16066	14760
Channel Y	15919	15920
Channel Z	15850	17630

5. Input Offset Measurement

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Input 10M Ω

	Average (μ V)	min. Offset (μ V)	max. Offset (μ V)	Std. Deviation (μ V)
Channel X	0.46	-1.79	2.61	0.63
Channel Y	-0.83	-1.53	-0.30	0.29
Channel Z	-0.50	-1.26	0.23	0.29

6. Input Offset Current

Nominal Input circuitry offset current on all channels: <25fA

7. Input Resistance (Typical values for information)

	Zeroing (kOhm)	Measuring (MOhm)
Channel X	200	200
Channel Y	200	200
Channel Z	200	200

8. Low Battery Alarm Voltage (Typical values for information)

Typical values	Alarm Level (VDC)
Supply (+ Vcc)	+7.9
Supply (- Vcc)	-7.6

9. Power Consumption (Typical values for information)

Typical values	Switched off (mA)	Stand by (mA)	Transmitting (mA)
Supply (+ Vcc)	+0.01	+6	+14
Supply (- Vcc)	-0.01	-8	-9

IMPORTANT NOTICE

USAGE OF THE DAE4

The DAE unit is a delicate, high precision instrument and requires careful treatment by the user. There are no serviceable parts inside the DAE. Special attention shall be given to the following points:

Battery Exchange: The battery cover of the DAE4 unit is closed using a screw, over tightening the screw may cause the threads inside the DAE to wear out.

Shipping of the DAE: Before shipping the DAE to SPEAG for calibration, remove the batteries and pack the DAE in an antistatic bag. This antistatic bag shall then be packed into a larger box or container which protects the DAE from impacts during transportation. The package shall be marked to indicate that a fragile instrument is inside.

E-Stop Failures: Touch detection may be malfunctioning due to broken magnets in the E-stop. Rough handling of the E-stop may lead to damage of these magnets. Touch and collision errors are often caused by dust and dirt accumulated in the E-stop. To prevent E-stop failure, the customer shall always mount the probe to the DAE carefully and keep the DAE unit in a non-dusty environment if not used for measurements.

Repair: Minor repairs are performed at no extra cost during the calibration. However, SPEAG reserves the right to charge for any repair especially if rough unprofessional handling caused the defect.

DASY Configuration Files: Since the exact values of the DAE input resistances, as measured during the calibration procedure of a DAE unit, are not used by the DASY software, a nominal value of 200 MOhm is given in the corresponding configuration file.

Important Note:

Warranty and calibration is void if the DAE unit is disassembled partly or fully by the Customer.

Important Note:

Never attempt to grease or oil the E-stop assembly. Cleaning and readjusting of the E-stop assembly is allowed by certified SPEAG personnel only and is part of the calibration procedure.

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To prevent damage of the DAE probe connector pins, use great care when installing the probe to the DAE. Carefully connect the probe with the connector notch oriented in the mating position. Avoid any rotational movement of the probe body versus the DAE while turning the locking nut of the connector. The same care shall be used when disconnecting the probe from the DAE.



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Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: SCS 0108

Client **BTL Inc.**
Guangdong

Certificate No: DAE4-1390_Nov24

CALIBRATION CERTIFICATE

Object DAE4 - SD 000 D04 BM - SN: 1390

Calibration procedure(s) QA CAL-06.v30
Calibration procedure for the data acquisition electronics (DAE)

Calibration date: November 14, 2024

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature $(22 \pm 3)^{\circ}\text{C}$ and humidity $< 70\%$.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Keithley Multimeter Type 2001	SN: 0810278	27-Aug-24 (No:40547)	Aug-25
Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Auto DAE Calibration Unit	SE UWS 053 AA 1001	23-Jan-24 (in house check)	In house check: Jan-25
Calibrator Box V2.1	SE UMS 006 AA 1002	23-Jan-24 (in house check)	In house check: Jan-25

Calibrated by:	Name Adrian Gehring	Function Laboratory Technician	Signature
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Approved by:	Sven Kühn	Technical Manager
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Issued: November 14, 2024

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Glossary

DAE	data acquisition electronics
Connector angle	information used in DASY system to align probe sensor X to the robot coordinate system.

Methods Applied and Interpretation of Parameters

- *DC Voltage Measurement:* Calibration Factor assessed for use in DASY system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.
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 - *Common mode sensitivity:* Influence of a positive or negative common mode voltage on the differential measurement.
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DC Voltage Measurement

A/D - Converter Resolution nominal

High Range: 1LSB = 6.1 μ V, full range = -100...+300 mV

Low Range: 1LSB = 61nV, full range = -1.....+3mV

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Calibration Factors	X	Y	Z
High Range	403.661 $\pm$ 0.02% (k=2)	403.375 $\pm$ 0.02% (k=2)	404.261 $\pm$ 0.02% (k=2)
Low Range	3.98099 $\pm$ 1.50% (k=2)	4.00380 $\pm$ 1.50% (k=2)	3.98504 $\pm$ 1.50% (k=2)

Connector Angle

Connector Angle to be used in DASY system	138.5 ° $\pm$ 1 °
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Appendix (Additional assessments outside the scope of SCS0108)

1. DC Voltage Linearity

High Range	Reading (μV)	Difference (μV)	Error (%)
Channel X + Input	199997.30	-0.08	-0.00
Channel X + Input	20004.96	1.27	0.01
Channel X - Input	-19999.95	1.13	-0.01
Channel Y + Input	199996.66	-0.38	-0.00
Channel Y + Input	20003.37	-0.22	-0.00
Channel Y - Input	-20002.10	-0.72	0.00
Channel Z + Input	199998.67	1.91	0.00
Channel Z + Input	20002.42	-1.15	-0.01
Channel Z - Input	-20003.76	-2.46	0.01

Low Range	Reading (μV)	Difference (μV)	Error (%)
Channel X + Input	2003.21	0.87	0.04
Channel X + Input	202.94	0.43	0.21
Channel X - Input	-197.11	0.14	-0.07
Channel Y + Input	2003.03	0.92	0.05
Channel Y + Input	201.93	-0.44	-0.22
Channel Y - Input	-197.91	-0.50	0.26
Channel Z + Input	2002.59	0.48	0.02
Channel Z + Input	201.36	-0.98	-0.48
Channel Z - Input	-198.92	-1.50	0.76

2. Common mode sensitivity

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Common mode Input Voltage (mV)	High Range Average Reading (μV)	Low Range Average Reading (μV)
Channel X	200	-2.95	-4.80
	- 200	5.42	4.18
Channel Y	200	16.24	15.86
	- 200	-17.69	-17.96
Channel Z	200	13.83	13.41
	- 200	-16.44	-16.27

3. Channel separation

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Input Voltage (mV)	Channel X (μV)	Channel Y (μV)	Channel Z (μV)
Channel X	200	-	1.30	-5.23
Channel Y	200	9.03	-	3.45
Channel Z	200	9.51	6.75	-

4. AD-Converter Values with inputs shorted

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	High Range (LSB)	Low Range (LSB)
Channel X	16121	15307
Channel Y	15813	15894
Channel Z	15723	15030

5. Input Offset Measurement

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Input 10M Ω

	Average (μ V)	min. Offset (μ V)	max. Offset (μ V)	Std. Deviation (μ V)
Channel X	0.73	-0.15	1.46	0.31
Channel Y	-0.58	-1.54	0.19	0.35
Channel Z	-1.16	-2.87	1.48	0.55

6. Input Offset Current

Nominal Input circuitry offset current on all channels: <25fA

7. Input Resistance (Typical values for information)

	Zeroing (kOhm)	Measuring (MOhm)
Channel X	200	200
Channel Y	200	200
Channel Z	200	200

8. Low Battery Alarm Voltage (Typical values for information)

Typical values	Alarm Level (VDC)
Supply (+ Vcc)	+7.9
Supply (- Vcc)	-7.6

9. Power Consumption (Typical values for information)

Typical values	Switched off (mA)	Stand by (mA)	Transmitting (mA)
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Accreditation No.: **SCS 0108**

Client **BTL**
Guangdong

Certificate No: **DAE4-1717_Apr24**

CALIBRATION CERTIFICATE

Object **DAE4 - SD 000 D04 BO - SN: 1717**

Calibration procedure(s) **QA CAL-06.v30**
Calibration procedure for the data acquisition electronics (DAE)

Calibration date: **April 18, 2024**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

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Calibrator Box V2.1	SE UMS 006 AA 1002	23-Jan-24 (in house check)	In house check: Jan-25

Calibrated by: Name **Adrian Gehring** Function **Laboratory Technician**

Approved by: **Sven Kühn** Technical Manager

Signature

Issued: April 18, 2024

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DC Voltage Measurement

A/D - Converter Resolution nominal

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Low Range: 1LSB = 61 nV, full range = -1.....+3mV

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Calibration Factors	X	Y	Z
High Range	404.281 $\pm$ 0.02% (k=2)	404.253 $\pm$ 0.02% (k=2)	404.473 $\pm$ 0.02% (k=2)
Low Range	3.98968 $\pm$ 1.50% (k=2)	3.97688 $\pm$ 1.50% (k=2)	3.99864 $\pm$ 1.50% (k=2)

Connector Angle

Connector Angle to be used in DASY system	11.0 ° $\pm$ 1 °
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Appendix (Additional assessments outside the scope of SCS0108)

1. DC Voltage Linearity

High Range	Reading (μV)	Difference (μV)	Error (%)
Channel X + Input	199996.23	1.51	0.00
Channel X + Input	20002.00	-0.75	-0.00
Channel X - Input	-19999.29	2.18	-0.01
Channel Y + Input	199996.80	2.10	0.00
Channel Y + Input	19999.02	-3.46	-0.02
Channel Y - Input	-20002.48	-0.81	0.00
Channel Z + Input	199995.10	0.47	0.00
Channel Z + Input	19998.23	-4.24	-0.02
Channel Z - Input	-20001.58	0.18	-0.00

Low Range	Reading (μV)	Difference (μV)	Error (%)
Channel X + Input	2001.62	0.04	0.00
Channel X + Input	202.51	0.62	0.31
Channel X - Input	-196.98	0.84	-0.42
Channel Y + Input	2001.18	-0.24	-0.01
Channel Y + Input	201.38	-0.26	-0.13
Channel Y - Input	-198.95	-0.88	0.44
Channel Z + Input	2001.65	0.13	0.01
Channel Z + Input	200.76	-0.98	-0.48
Channel Z - Input	-199.07	-1.02	0.52

2. Common mode sensitivity

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Common mode Input Voltage (mV)	High Range Average Reading (μV)	Low Range Average Reading (μV)
Channel X	200	12.80	10.85
	- 200	-9.43	-11.22
Channel Y	200	10.39	9.87
	- 200	-11.40	-11.65
Channel Z	200	-4.51	-4.21
	- 200	2.73	2.65

3. Channel separation

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Input Voltage (mV)	Channel X (μV)	Channel Y (μV)	Channel Z (μV)
Channel X	200	-	-0.25	-2.94
Channel Y	200	6.17	-	2.45
Channel Z	200	8.06	3.74	-

4. AD-Converter Values with inputs shorted

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	High Range (LSB)	Low Range (LSB)
Channel X	15693	16510
Channel Y	15976	14320
Channel Z	16100	12824

5. Input Offset Measurement

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Input 10M Ω

	Average (μ V)	min. Offset (μ V)	max. Offset (μ V)	Std. Deviation (μ V)
Channel X	1.23	0.21	2.53	0.40
Channel Y	-0.48	-1.34	0.22	0.32
Channel Z	-0.10	-0.86	0.55	0.29

6. Input Offset Current

Nominal Input circuitry offset current on all channels: <25fA

7. Input Resistance (Typical values for information)

	Zeroing (kOhm)	Measuring (MOhm)
Channel X	200	200
Channel Y	200	200
Channel Z	200	200

8. Low Battery Alarm Voltage (Typical values for information)

Typical values	Alarm Level (VDC)
Supply (+ Vcc)	+7.9
Supply (- Vcc)	-7.6

9. Power Consumption (Typical values for information)

Typical values	Switched off (mA)	Stand by (mA)	Transmitting (mA)
Supply (+ Vcc)	+0.01	+6	+14
Supply (- Vcc)	-0.01	-8	-9



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The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: SCS 0108

Client

BTL Inc.
Guangdong

Certificate No.

EX-7544_Apr24/2

CALIBRATION CERTIFICATE (Replacement of No: EX-7544_Apr24)

Object EX3DV4 - SN:7544

Calibration procedure(s) QA CAL-01.v10, QA CAL-12.v10, QA CAL-14.v7, QA CAL-23.v6,
QA CAL-25.v8
Calibration procedure for dosimetric E-field probes

Calibration date April 03, 2024

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature $(22 \pm 3)^\circ\text{C}$ and humidity $< 70\%$.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID	Cal Date (Certificate No.)	Scheduled Calibration
Power meter NRP2	SN: 104778	26-Mar-24 (No. 217-04036/04037)	Mar-25
Power sensor NRP-Z91	SN: 103244	26-Mar-24 (No. 217-04036)	Mar-25
OCP DAK-3.5 (weighted)	SN: 1249	05-Oct-23 (OCP-DAK3.5-1249_Oct23)	Oct-24
OCP DAK-12	SN: 1016	05-Oct-23 (OCP-DAK12-1016_Oct23)	Oct-24
Reference 20 dB Attenuator	SN: CC2552 (20x)	26-Mar-24 (No. 217-04046)	Mar-25
DAE4	SN: 660	23-Feb-24 (No. DAE4-660_Feb24)	Feb-25
Reference Probe EX3DV4	SN: 7349	03-Nov-23 (No. EX3-7349_Nov23)	Nov-24

Secondary Standards	ID	Check Date (in house)	Scheduled Check
Power meter E4419B	SN: GB41293874	06-Apr-16 (in house check Jun-22)	In house check: Jun-24
Power sensor E4412A	SN: MY41498087	06-Apr-16 (in house check Jun-22)	In house check: Jun-24
Power sensor E4412A	SN: 000110210	06-Apr-16 (in house check Jun-22)	In house check: Jun-24
RF generator HP 8648C	SN: US3642U01700	04-Aug-99 (in house check Jun-22)	In house check: Jun-24
Network Analyzer E8358A	SN: US41080477	31-Mar-14 (in house check Oct-22)	In house check: Oct-24

	Name	Function	Signature
Calibrated by	Joanna Lleshaj	Laboratory Technician	
Approved by	Sven Kühn	Technical Manager	

Issued: May 21, 2024

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

Calibration Laboratory of

Schmid & Partner
Engineering AG

Zeughausstrasse 43, 8004 Zurich, Switzerland



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Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 0108**

Glossary

TSL	tissue simulating liquid
NORM _{x,y,z}	sensitivity in free space
ConvF	sensitivity in TSL / NORM _{x,y,z}
DCP	diode compression point
CF	crest factor (1/duty_cycle) of the RF signal
A, B, C, D	modulation dependent linearization parameters
Polarization φ	φ rotation around probe axis
Polarization θ	θ rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e., $\theta = 0$ is normal to probe axis
Connector Angle	information used in DASY system to align probe sensor X to the robot coordinate system

Calibration is Performed According to the Following Standards:

- IEC/IEEE 62209-1528, "Measurement Procedure For The Assessment Of Specific Absorption Rate Of Human Exposure To Radio Frequency Fields From Hand-Held And Body-Worn Wireless Communication Devices – Part 1528: Human Models, Instrumentation And Procedures (Frequency Range of 4 MHz to 10 GHz)", October 2020.
- KDB 865664, "SAR Measurement Requirements for 100 MHz to 6 GHz"

Methods Applied and Interpretation of Parameters:

- NORM_{x,y,z}**: Assessed for E-field polarization $\theta = 0$ ($f \leq 900$ MHz in TEM-cell; $f > 1800$ MHz: R22 waveguide). NORM_{x,y,z} are only intermediate values, i.e., the uncertainties of NORM_{x,y,z} does not affect the E²-field uncertainty inside TSL (see below ConvF).
- NORM(f)_{x,y,z} = NORM_{x,y,z} * frequency_response** (see Frequency Response Chart). This linearization is implemented in DASY4 software versions later than 4.2. The uncertainty of the frequency response is included in the stated uncertainty of ConvF.
- DCP_{x,y,z}**: DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal. DCP does not depend on frequency nor media.
- PAR**: PAR is the Peak to Average Ratio that is not calibrated but determined based on the signal characteristics
- A_{x,y,z}; B_{x,y,z}; C_{x,y,z}; D_{x,y,z}; VR_{x,y,z}**: A, B, C, D are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode.
- ConvF and Boundary Effect Parameters**: Assessed in flat phantom using E-field (or Temperature Transfer Standard for $f \leq 800$ MHz) and inside waveguide using analytical field distributions based on power measurements for $f > 800$ MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty values are given. These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to NORM_{x,y,z} * ConvF whereby the uncertainty corresponds to that given for ConvF. A frequency dependent ConvF is used in DASY version 4.4 and higher which allows extending the validity from ± 50 MHz to ± 100 MHz.
- Spherical isotropy (3D deviation from isotropy)**: in a field of low gradients realized using a flat phantom exposed by a patch antenna.
- Sensor Offset**: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- Connector Angle**: The angle is assessed using the information gained by determining the NORM_x (no uncertainty required).

Parameters of Probe: EX3DV4 - SN:7544

Basic Calibration Parameters

	Sensor X	Sensor Y	Sensor Z	Unc ($k = 2$)
Norm ($\mu\text{V}/(\text{V}/\text{m})^2$) ^A	0.66	0.55	0.62	$\pm 10.1\%$
DCP (mV) ^B	100.2	98.3	100.4	$\pm 4.7\%$

Calibration Results for Modulation Response

UID	Communication System Name		A dB	B dB $\sqrt{\mu\text{V}}$	C	D dB	VR mV	Max dev.	Max Unc ^E $k = 2$
0	CW	X	0.00	0.00	1.00	0.00	134.9	$\pm 1.2\%$	$\pm 4.7\%$
		Y	0.00	0.00	1.00		133.1		
		Z	0.00	0.00	1.00		130.3		
10352	Pulse Waveform (200Hz, 10%)	X	20.00	89.69	19.93	10.00	60.0	$\pm 3.0\%$	$\pm 9.6\%$
		Y	20.00	95.21	23.01		60.0		
		Z	20.00	91.79	21.31		60.0		
10353	Pulse Waveform (200Hz, 20%)	X	20.00	90.17	19.33	6.99	80.0	$\pm 1.4\%$	$\pm 9.6\%$
		Y	20.00	98.46	23.56		80.0		
		Z	20.00	92.60	20.87		80.0		
10354	Pulse Waveform (200Hz, 40%)	X	20.00	93.11	19.69	3.98	95.0	$\pm 1.0\%$	$\pm 9.6\%$
		Y	20.00	104.03	24.84		95.0		
		Z	20.00	96.22	21.51		95.0		
10355	Pulse Waveform (200Hz, 60%)	X	20.00	98.60	21.22	2.22	120.0	$\pm 1.0\%$	$\pm 9.6\%$
		Y	20.00	110.61	26.49		120.0		
		Z	20.00	101.77	22.98		120.0		
10387	QPSK Waveform, 1 MHz	X	1.79	66.39	15.39	1.00	150.0	$\pm 1.9\%$	$\pm 9.6\%$
		Y	1.73	65.18	14.69		150.0		
		Z	1.73	65.86	15.01		150.0		
10388	QPSK Waveform, 10 MHz	X	2.38	68.64	16.10	0.00	150.0	$\pm 1.0\%$	$\pm 9.6\%$
		Y	2.27	67.41	15.35		150.0		
		Z	2.27	67.84	15.67		150.0		
10396	64-QAM Waveform, 100 kHz	X	3.13	71.63	19.43	3.01	150.0	$\pm 0.8\%$	$\pm 9.6\%$
		Y	2.81	69.03	18.11		150.0		
		Z	3.03	70.92	19.10		150.0		
10399	64-QAM Waveform, 40 MHz	X	3.64	67.52	16.01	0.00	150.0	$\pm 0.8\%$	$\pm 9.6\%$
		Y	3.59	66.99	15.68		150.0		
		Z	3.57	67.14	15.80		150.0		
10414	WLAN CCDF, 64-QAM, 40 MHz	X	4.83	65.27	15.37	0.00	150.0	$\pm 2.0\%$	$\pm 9.6\%$
		Y	4.82	64.94	15.17		150.0		
		Z	4.96	65.71	15.58		150.0		

Note: For details on UID parameters see Appendix

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor $k=2$, which for a normal distribution corresponds to a coverage probability of approximately 95%.

^A The uncertainties of Norm X,Y,Z do not affect the E^2 -field uncertainty inside TSL (see Page 5).

^B Linearization parameter uncertainty for maximum specified field strength.

^E Uncertainty is determined using the max. deviation from linear response applying rectangular distribution and is expressed for the square of the field value.

Parameters of Probe: EX3DV4 - SN:7544**Sensor Model Parameters**

	C1 fF	C2 fF	α V⁻¹	T1 msV⁻²	T2 msV⁻¹	T3 ms	T4 V⁻²	T5 V⁻¹	T6
x	50.4	374.94	35.31	22.13	0.00	5.06	1.36	0.21	1.01
y	54.7	413.76	36.28	13.89	0.09	5.10	0.67	0.34	1.01
z	48.8	365.00	35.63	23.58	0.00	5.09	1.38	0.21	1.01

Other Probe Parameters

Sensor Arrangement	Triangular
Connector Angle	-15.6°
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	disabled
Probe Overall Length	337 mm
Probe Body Diameter	10 mm
Tip Length	9 mm
Tip Diameter	2.5 mm
Probe Tip to Sensor X Calibration Point	1 mm
Probe Tip to Sensor Y Calibration Point	1 mm
Probe Tip to Sensor Z Calibration Point	1 mm
Recommended Measurement Distance from Surface	1.4 mm

Note: Measurement distance from surface can be increased to 3–4 mm for an *Area Scan* job.

Parameters of Probe: EX3DV4 - SN:7544

Calibration Parameter Determined in Head Tissue Simulating Media

f (MHz) ^C	Relative Permittivity ^F	Conductivity ^F (S/m)	ConvF X	ConvF Y	ConvF Z	Alpha ^G	Depth ^G (mm)	Unc (k = 2)
750	41.9	0.89	9.68	9.48	9.54	0.36	1.27	±11.0%
835	41.5	0.90	9.34	9.18	9.30	0.35	1.27	±11.0%
1750	40.1	1.37	8.19	7.93	7.97	0.26	1.27	±11.0%
1900	40.0	1.40	8.01	7.77	7.76	0.28	1.27	±11.0%
2300	39.5	1.67	7.66	7.43	7.50	0.31	1.27	±11.0%
2450	39.2	1.80	7.51	7.27	7.34	0.30	1.27	±11.0%
2600	39.0	1.96	7.34	7.11	7.18	0.29	1.27	±11.0%
3500	37.9	2.91	6.93	6.78	6.83	0.35	1.27	±13.1%
3700	37.7	3.12	6.84	6.65	6.72	0.35	1.27	±13.1%
5250	35.9	4.71	5.48	5.36	5.39	0.36	1.62	±13.1%
5600	35.5	5.07	4.74	4.48	4.59	0.38	1.75	±13.1%
5750	35.4	5.22	4.96	4.67	4.80	0.35	1.84	±13.1%

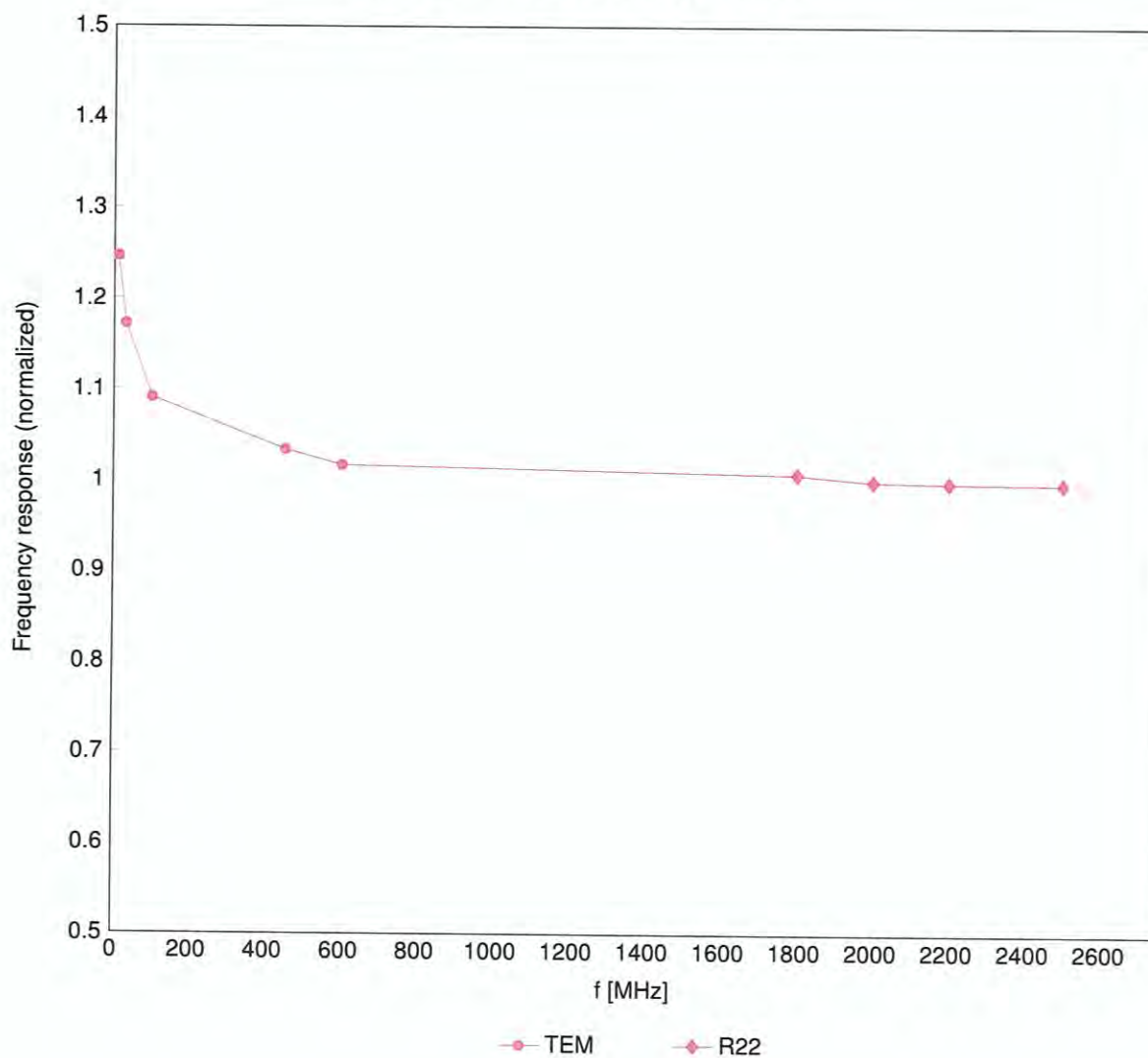
^C Frequency validity above 300 MHz of ±100 MHz only applies for DASY v4.4 and higher (see Page 2), else it is restricted to ±50 MHz. The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band. Frequency validity below 300 MHz is ±10, 25, 40, 50 and 70 MHz for ConvF assessments at 30, 64, 128, 150 and 220 MHz respectively. Validity of ConvF assessed at 6 MHz is 4–9 MHz, and ConvF assessed at 13 MHz is 9–19 MHz. Above 5 GHz frequency validity can be extended to ±110 MHz.

^F The probes are calibrated using tissue simulating liquids (TSL) that deviate for ϵ and σ by less than ±5% from the target values (typically better than ±3%) and are valid for TSL with deviations of up to ±10% if SAR correction is applied.

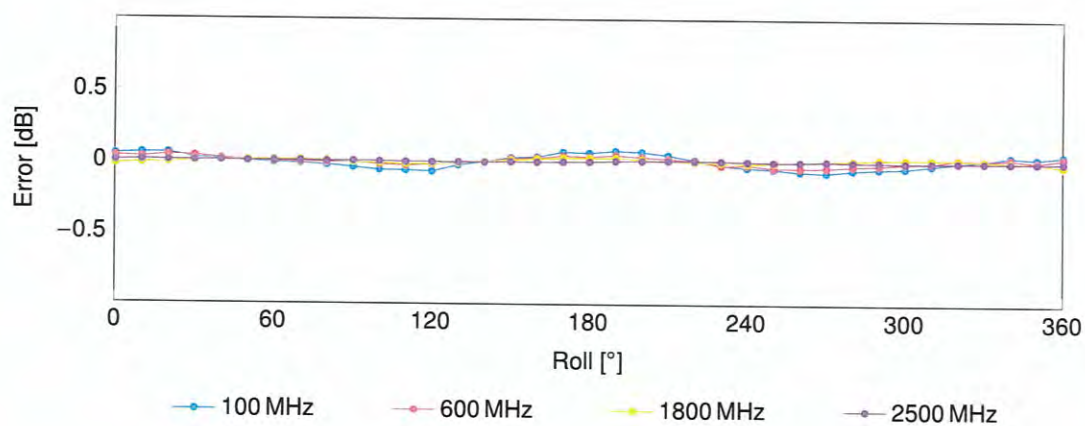
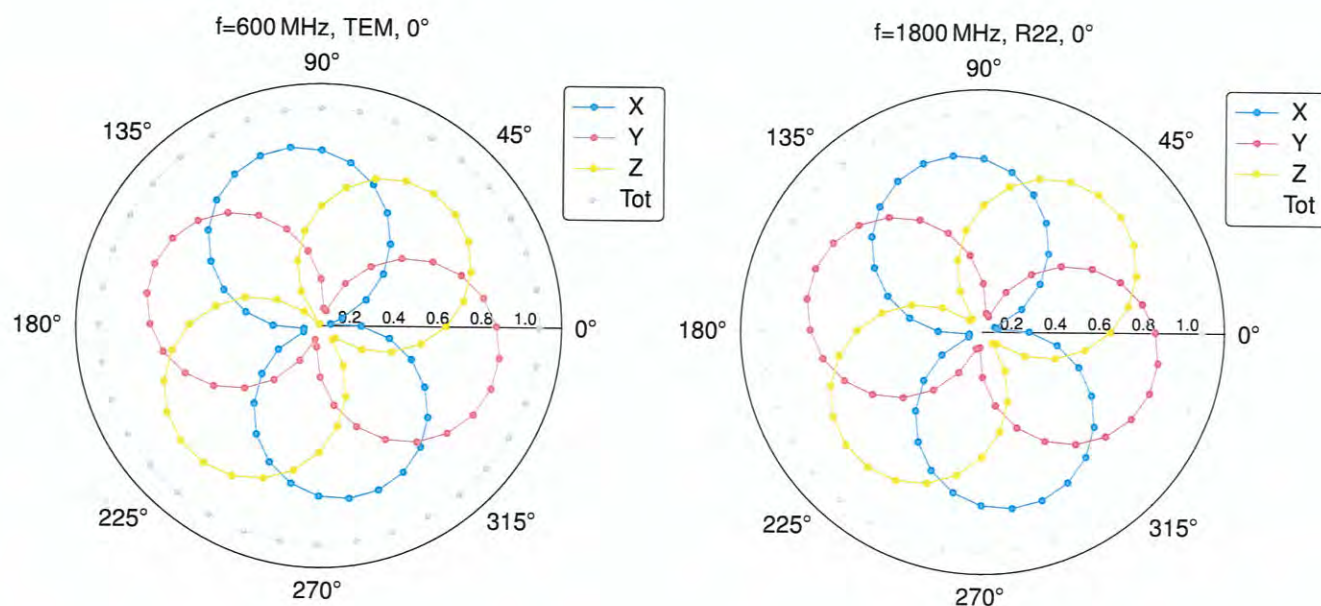
^G Alpha/Depth are determined during calibration. SPEAG warrants that the remaining deviation due to the boundary effect after compensation is always less than ±1% for frequencies below 3 GHz and below ±2% for frequencies between 3–6 GHz at any distance larger than half the probe tip diameter from the boundary.

Frequency Response of E-Field

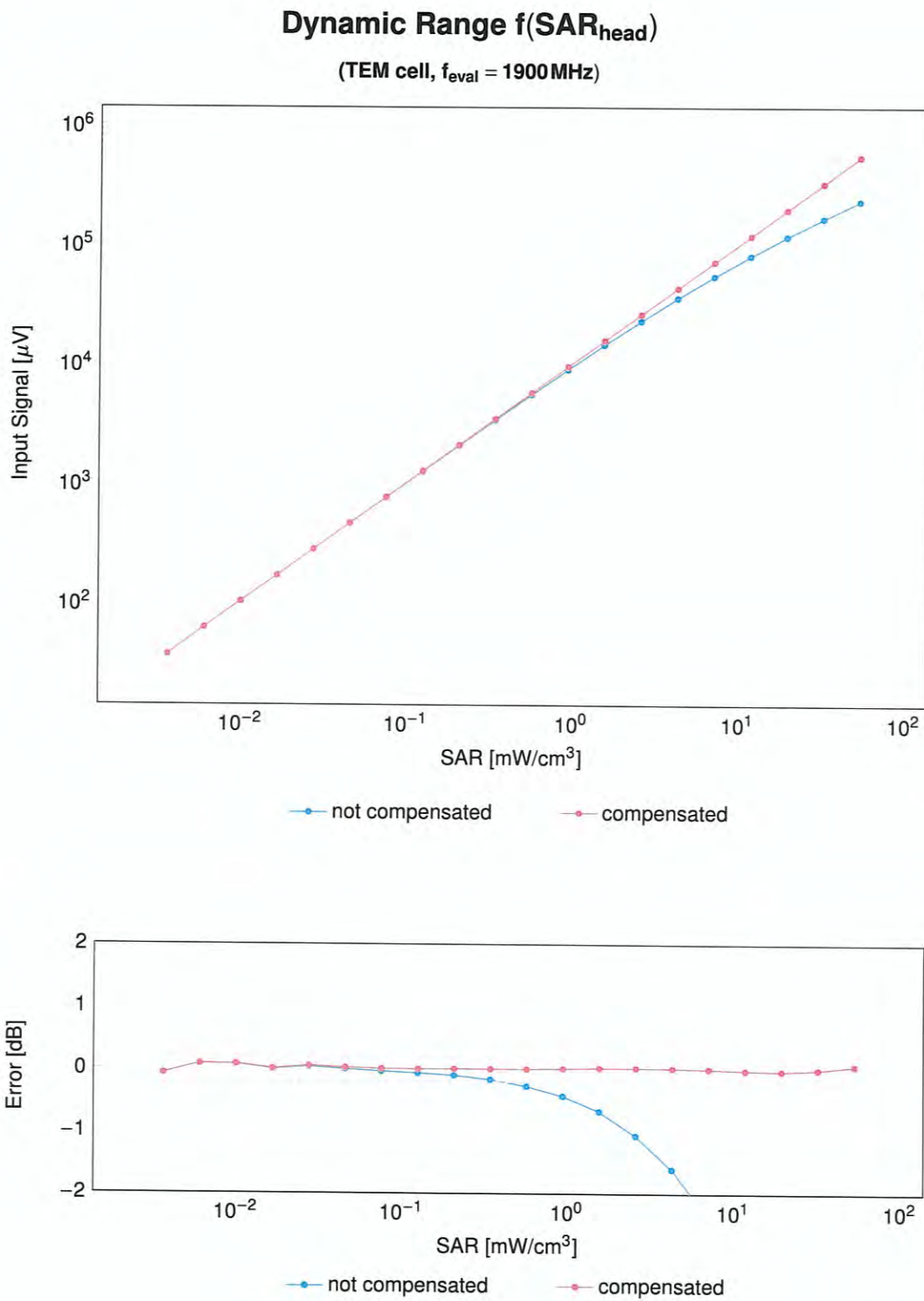
(TEM-Cell:ifi110 EXX, Waveguide:R22)



Uncertainty of Frequency Response of E-field: $\pm 6.3\%$ ($k=2$)

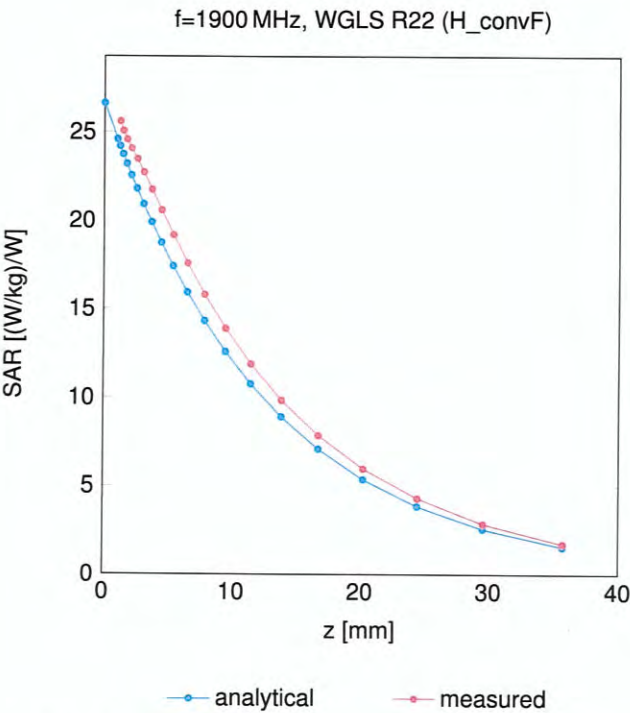
Receiving Pattern (ϕ), $\vartheta = 0^\circ$ 

Uncertainty of Axial Isotropy Assessment: $\pm 0.5\%$ ($k=2$)



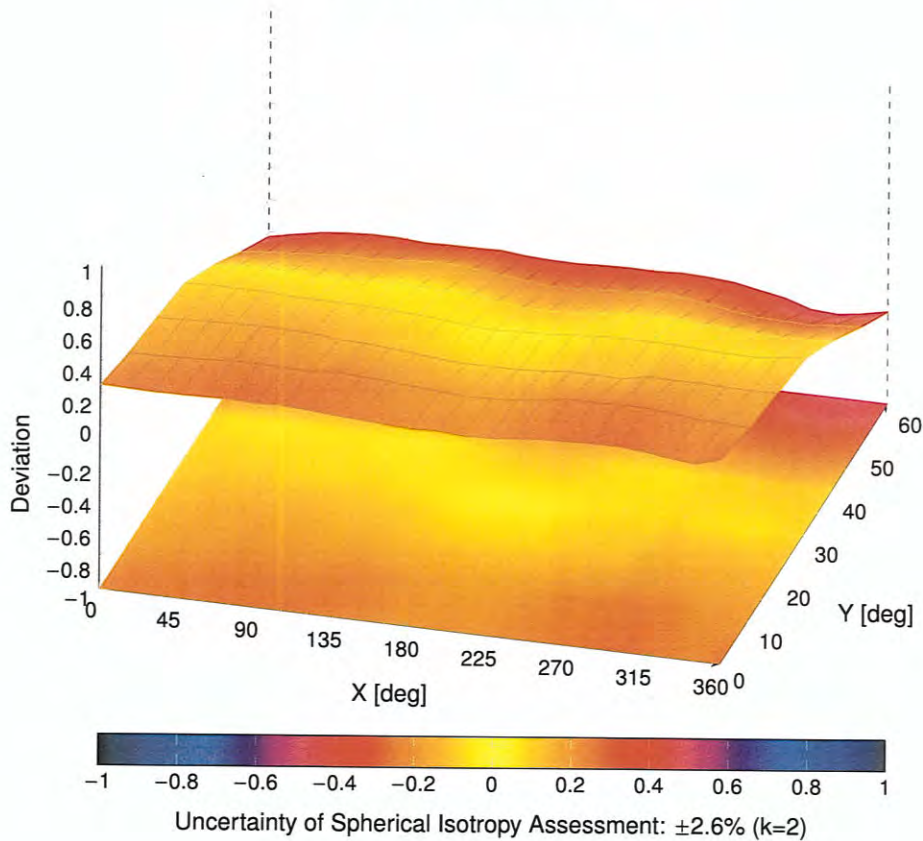
Uncertainty of Linearity Assessment: ±0.6% (k=2)

Conversion Factor Assessment



Deviation from Isotropy in Liquid

Error (ϕ, θ), f = 900 MHz



Appendix: Modulation Calibration Parameters

UID	Rev	Communication System Name	Group	PAR (dB)	Unc ^E $k = 2$
0		CW	CW	0.00	±4.7
10010	CAB	SAR Validation (Square, 100 ms, 10 ms)	Test	10.00	±9.6
10011	CAC	UMTS-FDD (WCDMA)	WCDMA	2.91	±9.6
10012	CAB	IEEE 802.11b WiFi 2.4 GHz (DSSS, 1 Mbps)	WLAN	1.87	±9.6
10013	CAB	IEEE 802.11g WiFi 2.4 GHz (DSSS-OFDM, 6 Mbps)	WLAN	9.46	±9.6
10021	DAC	GSM-FDD (TDMA, GMSK)	GSM	9.39	±9.6
10023	DAC	GPRS-FDD (TDMA, GMSK, TN 0)	GSM	9.57	±9.6
10024	DAC	GPRS-FDD (TDMA, GMSK, TN 0-1)	GSM	6.56	±9.6
10025	DAC	EDGE-FDD (TDMA, 8PSK, TN 0)	GSM	12.62	±9.6
10026	DAC	EDGE-FDD (TDMA, 8PSK, TN 0-1)	GSM	9.55	±9.6
10027	DAC	GPRS-FDD (TDMA, GMSK, TN 0-1-2)	GSM	4.80	±9.6
10028	DAC	GPRS-FDD (TDMA, GMSK, TN 0-1-2-3)	GSM	3.55	±9.6
10029	DAC	EDGE-FDD (TDMA, 8PSK, TN 0-1-2)	GSM	7.78	±9.6
10030	CAA	IEEE 802.15.1 Bluetooth (GFSK, DH1)	Bluetooth	5.30	±9.6
10031	CAA	IEEE 802.15.1 Bluetooth (GFSK, DH3)	Bluetooth	1.87	±9.6
10032	CAA	IEEE 802.15.1 Bluetooth (GFSK, DH5)	Bluetooth	1.16	±9.6
10033	CAA	IEEE 802.15.1 Bluetooth (PI/4-DQPSK, DH1)	Bluetooth	7.74	±9.6
10034	CAA	IEEE 802.15.1 Bluetooth (PI/4-DQPSK, DH3)	Bluetooth	4.53	±9.6
10035	CAA	IEEE 802.15.1 Bluetooth (PI/4-DQPSK, DH5)	Bluetooth	3.83	±9.6
10036	CAA	IEEE 802.15.1 Bluetooth (8-DPSK, DH1)	Bluetooth	8.01	±9.6
10037	CAA	IEEE 802.15.1 Bluetooth (8-DPSK, DH3)	Bluetooth	4.77	±9.6
10038	CAA	IEEE 802.15.1 Bluetooth (8-DPSK, DH5)	Bluetooth	4.10	±9.6
10039	CAB	CDMA2000 (1xRTT, RC1)	CDMA2000	4.57	±9.6
10042	CAB	IS-54 / IS-136 FDD (TDMA/FDM, PI/4-DQPSK, Halfrate)	AMPS	7.78	±9.6
10044	CAA	IS-91/EIA/TIA-553 FDD (FDMA, FM)	AMPS	0.00	±9.6
10048	CAA	DECT (TDD, TDMA/FDM, GFSK, Full Slot, 24)	DECT	13.80	±9.6
10049	CAA	DECT (TDD, TDMA/FDM, GFSK, Double Slot, 12)	DECT	10.79	±9.6
10056	CAA	UMTS-TDD (TD-SCDMA, 1.28 Mcps)	TD-SCDMA	11.01	±9.6
10058	DAC	EDGE-FDD (TDMA, 8PSK, TN 0-1-2-3)	GSM	6.52	±9.6
10059	CAB	IEEE 802.11b WiFi 2.4 GHz (DSSS, 2 Mbps)	WLAN	2.12	±9.6
10060	CAB	IEEE 802.11b WiFi 2.4 GHz (DSSS, 5.5 Mbps)	WLAN	2.83	±9.6
10061	CAB	IEEE 802.11b WiFi 2.4 GHz (DSSS, 11 Mbps)	WLAN	3.60	±9.6
10062	CAE	IEEE 802.11a/h WiFi 5 GHz (OFDM, 6 Mbps)	WLAN	8.68	±9.6
10063	CAE	IEEE 802.11a/h WiFi 5 GHz (OFDM, 9 Mbps)	WLAN	8.63	±9.6
10064	CAE	IEEE 802.11a/h WiFi 5 GHz (OFDM, 12 Mbps)	WLAN	9.09	±9.6
10065	CAE	IEEE 802.11a/h WiFi 5 GHz (OFDM, 18 Mbps)	WLAN	9.00	±9.6
10066	CAE	IEEE 802.11a/h WiFi 5 GHz (OFDM, 24 Mbps)	WLAN	9.38	±9.6
10067	CAE	IEEE 802.11a/h WiFi 5 GHz (OFDM, 36 Mbps)	WLAN	10.12	±9.6
10068	CAE	IEEE 802.11a/h WiFi 5 GHz (OFDM, 48 Mbps)	WLAN	10.24	±9.6
10069	CAE	IEEE 802.11a/h WiFi 5 GHz (OFDM, 54 Mbps)	WLAN	10.56	±9.6
10071	CAB	IEEE 802.11g WiFi 2.4 GHz (DSSS/OFDM, 9 Mbps)	WLAN	9.83	±9.6
10072	CAB	IEEE 802.11g WiFi 2.4 GHz (DSSS/OFDM, 12 Mbps)	WLAN	9.62	±9.6
10073	CAB	IEEE 802.11g WiFi 2.4 GHz (DSSS/OFDM, 18 Mbps)	WLAN	9.94	±9.6
10074	CAB	IEEE 802.11g WiFi 2.4 GHz (DSSS/OFDM, 24 Mbps)	WLAN	10.30	±9.6
10075	CAB	IEEE 802.11g WiFi 2.4 GHz (DSSS/OFDM, 36 Mbps)	WLAN	10.77	±9.6
10076	CAB	IEEE 802.11g WiFi 2.4 GHz (DSSS/OFDM, 48 Mbps)	WLAN	10.94	±9.6
10077	CAB	IEEE 802.11g WiFi 2.4 GHz (DSSS/OFDM, 54 Mbps)	WLAN	11.00	±9.6
10081	CAB	CDMA2000 (1xRTT, RC3)	CDMA2000	3.97	±9.6
10082	CAB	IS-54 / IS-136 FDD (TDMA/FDM, PI/4-DQPSK, Fullrate)	AMPS	4.77	±9.6
10090	DAC	GPRS-FDD (TDMA, GMSK, TN 0-4)	GSM	6.56	±9.6
10097	CAC	UMTS-FDD (HSDPA)	WCDMA	3.98	±9.6
10098	CAC	UMTS-FDD (HSUPA, Subtest 2)	WCDMA	3.98	±9.6
10099	DAC	EDGE-FDD (TDMA, 8PSK, TN 0-4)	GSM	9.55	±9.6
10100	CAF	LTE-FDD (SC-FDMA, 100% RB, 20 MHz, QPSK)	LTE-FDD	5.67	±9.6
10101	CAF	LTE-FDD (SC-FDMA, 100% RB, 20 MHz, 16-QAM)	LTE-FDD	6.42	±9.6
10102	CAF	LTE-FDD (SC-FDMA, 100% RB, 20 MHz, 64-QAM)	LTE-FDD	6.60	±9.6
10103	CAH	LTE-TDD (SC-FDMA, 100% RB, 20 MHz, QPSK)	LTE-TDD	9.29	±9.6
10104	CAH	LTE-TDD (SC-FDMA, 100% RB, 20 MHz, 16-QAM)	LTE-TDD	9.97	±9.6
10105	CAH	LTE-TDD (SC-FDMA, 100% RB, 20 MHz, 64-QAM)	LTE-TDD	10.01	±9.6
10108	CAH	LTE-FDD (SC-FDMA, 100% RB, 10 MHz, QPSK)	LTE-FDD	5.80	±9.6
10109	CAH	LTE-FDD (SC-FDMA, 100% RB, 10 MHz, 16-QAM)	LTE-FDD	6.43	±9.6
10110	CAH	LTE-FDD (SC-FDMA, 100% RB, 5 MHz, QPSK)	LTE-FDD	5.75	±9.6
10111	CAH	LTE-FDD (SC-FDMA, 100% RB, 5 MHz, 16-QAM)	LTE-FDD	6.44	±9.6

UID	Rev	Communication System Name	Group	PAR (dB)	Unc ^E $k = 2$
10112	CAH	LTE-FDD (SC-FDMA, 100% RB, 10 MHz, 64-QAM)	LTE-FDD	6.59	±9.6
10113	CAH	LTE-FDD (SC-FDMA, 100% RB, 5 MHz, 64-QAM)	LTE-FDD	6.62	±9.6
10114	CAE	IEEE 802.11n (HT Greenfield, 13.5 Mbps, BPSK)	WLAN	8.10	±9.6
10115	CAE	IEEE 802.11n (HT Greenfield, 81 Mbps, 16-QAM)	WLAN	8.46	±9.6
10116	CAE	IEEE 802.11n (HT Greenfield, 135 Mbps, 64-QAM)	WLAN	8.15	±9.6
10117	CAE	IEEE 802.11n (HT Mixed, 13.5 Mbps, BPSK)	WLAN	8.07	±9.6
10118	CAE	IEEE 802.11n (HT Mixed, 81 Mbps, 16-QAM)	WLAN	8.59	±9.6
10119	CAE	IEEE 802.11n (HT Mixed, 135 Mbps, 64-QAM)	WLAN	8.13	±9.6
10140	CAF	LTE-FDD (SC-FDMA, 100% RB, 15 MHz, 16-QAM)	LTE-FDD	6.49	±9.6
10141	CAF	LTE-FDD (SC-FDMA, 100% RB, 15 MHz, 64-QAM)	LTE-FDD	6.53	±9.6
10142	CAF	LTE-FDD (SC-FDMA, 100% RB, 3 MHz, QPSK)	LTE-FDD	5.73	±9.6
10143	CAF	LTE-FDD (SC-FDMA, 100% RB, 3 MHz, 16-QAM)	LTE-FDD	6.35	±9.6
10144	CAF	LTE-FDD (SC-FDMA, 100% RB, 3 MHz, 64-QAM)	LTE-FDD	6.65	±9.6
10145	CAG	LTE-FDD (SC-FDMA, 100% RB, 1.4 MHz, QPSK)	LTE-FDD	5.76	±9.6
10146	CAG	LTE-FDD (SC-FDMA, 100% RB, 1.4 MHz, 16-QAM)	LTE-FDD	6.41	±9.6
10147	CAG	LTE-FDD (SC-FDMA, 100% RB, 1.4 MHz, 64-QAM)	LTE-FDD	6.72	±9.6
10149	CAF	LTE-FDD (SC-FDMA, 50% RB, 20 MHz, 16-QAM)	LTE-FDD	6.42	±9.6
10150	CAF	LTE-FDD (SC-FDMA, 50% RB, 20 MHz, 64-QAM)	LTE-FDD	6.60	±9.6
10151	CAH	LTE-TDD (SC-FDMA, 50% RB, 20 MHz, QPSK)	LTE-TDD	9.28	±9.6
10152	CAH	LTE-TDD (SC-FDMA, 50% RB, 20 MHz, 16-QAM)	LTE-TDD	9.92	±9.6
10153	CAH	LTE-TDD (SC-FDMA, 50% RB, 20 MHz, 64-QAM)	LTE-TDD	10.05	±9.6
10154	CAH	LTE-FDD (SC-FDMA, 50% RB, 10 MHz, QPSK)	LTE-FDD	5.75	±9.6
10155	CAH	LTE-FDD (SC-FDMA, 50% RB, 10 MHz, 16-QAM)	LTE-FDD	6.43	±9.6
10156	CAH	LTE-FDD (SC-FDMA, 50% RB, 5 MHz, QPSK)	LTE-FDD	5.79	±9.6
10157	CAH	LTE-FDD (SC-FDMA, 50% RB, 5 MHz, 16-QAM)	LTE-FDD	6.49	±9.6
10158	CAH	LTE-FDD (SC-FDMA, 50% RB, 10 MHz, 64-QAM)	LTE-FDD	6.62	±9.6
10159	CAH	LTE-FDD (SC-FDMA, 50% RB, 5 MHz, 64-QAM)	LTE-FDD	6.56	±9.6
10160	CAF	LTE-FDD (SC-FDMA, 50% RB, 15 MHz, QPSK)	LTE-FDD	5.82	±9.6
10161	CAF	LTE-FDD (SC-FDMA, 50% RB, 15 MHz, 16-QAM)	LTE-FDD	6.43	±9.6
10162	CAF	LTE-FDD (SC-FDMA, 50% RB, 15 MHz, 64-QAM)	LTE-FDD	6.58	±9.6
10166	CAG	LTE-FDD (SC-FDMA, 50% RB, 1.4 MHz, QPSK)	LTE-FDD	5.46	±9.6
10167	CAG	LTE-FDD (SC-FDMA, 50% RB, 1.4 MHz, 16-QAM)	LTE-FDD	6.21	±9.6
10168	CAG	LTE-FDD (SC-FDMA, 50% RB, 1.4 MHz, 64-QAM)	LTE-FDD	6.79	±9.6
10169	CAF	LTE-FDD (SC-FDMA, 1 RB, 20 MHz, QPSK)	LTE-FDD	5.73	±9.6
10170	CAF	LTE-FDD (SC-FDMA, 1 RB, 20 MHz, 16-QAM)	LTE-FDD	6.52	±9.6
10171	AAF	LTE-FDD (SC-FDMA, 1 RB, 20 MHz, 64-QAM)	LTE-FDD	6.49	±9.6
10172	CAH	LTE-TDD (SC-FDMA, 1 RB, 20 MHz, QPSK)	LTE-TDD	9.21	±9.6
10173	CAH	LTE-TDD (SC-FDMA, 1 RB, 20 MHz, 16-QAM)	LTE-TDD	9.48	±9.6
10174	CAH	LTE-TDD (SC-FDMA, 1 RB, 20 MHz, 64-QAM)	LTE-TDD	10.25	±9.6
10175	CAH	LTE-FDD (SC-FDMA, 1 RB, 10 MHz, QPSK)	LTE-FDD	5.72	±9.6
10176	CAH	LTE-FDD (SC-FDMA, 1 RB, 10 MHz, 16-QAM)	LTE-FDD	6.52	±9.6
10177	CAJ	LTE-FDD (SC-FDMA, 1 RB, 5 MHz, QPSK)	LTE-FDD	5.73	±9.6
10178	CAH	LTE-FDD (SC-FDMA, 1 RB, 5 MHz, 16-QAM)	LTE-FDD	6.52	±9.6
10179	CAH	LTE-FDD (SC-FDMA, 1 RB, 10 MHz, 64-QAM)	LTE-FDD	6.50	±9.6
10180	CAH	LTE-FDD (SC-FDMA, 1 RB, 5 MHz, 64-QAM)	LTE-FDD	6.50	±9.6
10181	CAF	LTE-FDD (SC-FDMA, 1 RB, 15 MHz, QPSK)	LTE-FDD	5.72	±9.6
10182	CAF	LTE-FDD (SC-FDMA, 1 RB, 15 MHz, 16-QAM)	LTE-FDD	6.52	±9.6
10183	AAE	LTE-FDD (SC-FDMA, 1 RB, 15 MHz, 64-QAM)	LTE-FDD	6.50	±9.6
10184	CAF	LTE-FDD (SC-FDMA, 1 RB, 3 MHz, QPSK)	LTE-FDD	5.73	±9.6
10185	CAF	LTE-FDD (SC-FDMA, 1 RB, 3 MHz, 16-QAM)	LTE-FDD	6.51	±9.6
10186	AAF	LTE-FDD (SC-FDMA, 1 RB, 3 MHz, 64-QAM)	LTE-FDD	6.50	±9.6
10187	CAG	LTE-FDD (SC-FDMA, 1 RB, 1.4 MHz, QPSK)	LTE-FDD	5.73	±9.6
10188	CAG	LTE-FDD (SC-FDMA, 1 RB, 1.4 MHz, 16-QAM)	LTE-FDD	6.52	±9.6
10189	AAG	LTE-FDD (SC-FDMA, 1 RB, 1.4 MHz, 64-QAM)	LTE-FDD	6.50	±9.6
10193	CAE	IEEE 802.11n (HT Greenfield, 6.5 Mbps, BPSK)	WLAN	8.09	±9.6
10194	CAE	IEEE 802.11n (HT Greenfield, 39 Mbps, 16-QAM)	WLAN	8.12	±9.6
10195	CAE	IEEE 802.11n (HT Greenfield, 65 Mbps, 64-QAM)	WLAN	8.21	±9.6
10196	CAE	IEEE 802.11n (HT Mixed, 6.5 Mbps, BPSK)	WLAN	8.10	±9.6
10197	CAE	IEEE 802.11n (HT Mixed, 39 Mbps, 16-QAM)	WLAN	8.13	±9.6
10198	CAE	IEEE 802.11n (HT Mixed, 65 Mbps, 64-QAM)	WLAN	8.27	±9.6
10219	CAE	IEEE 802.11n (HT Mixed, 7.2 Mbps, BPSK)	WLAN	8.03	±9.6
10220	CAE	IEEE 802.11n (HT Mixed, 43.3 Mbps, 16-QAM)	WLAN	8.13	±9.6
10221	CAE	IEEE 802.11n (HT Mixed, 72.2 Mbps, 64-QAM)	WLAN	8.27	±9.6
10222	CAE	IEEE 802.11n (HT Mixed, 15 Mbps, BPSK)	WLAN	8.06	±9.6
10223	CAE	IEEE 802.11n (HT Mixed, 90 Mbps, 16-QAM)	WLAN	8.48	±9.6
10224	CAE	IEEE 802.11n (HT Mixed, 150 Mbps, 64-QAM)	WLAN	8.08	±9.6

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10225	CAC	UMTS-FDD (HSPA+)	WCDMA	5.97	±9.6
10226	CAC	LTE-TDD (SC-FDMA, 1 RB, 1.4 MHz, 16-QAM)	LTE-TDD	9.49	±9.6
10227	CAC	LTE-TDD (SC-FDMA, 1 RB, 1.4 MHz, 64-QAM)	LTE-TDD	10.26	±9.6
10228	CAC	LTE-TDD (SC-FDMA, 1 RB, 1.4 MHz, QPSK)	LTE-TDD	9.22	±9.6
10229	CAE	LTE-TDD (SC-FDMA, 1 RB, 3 MHz, 16-QAM)	LTE-TDD	9.48	±9.6
10230	CAE	LTE-TDD (SC-FDMA, 1 RB, 3 MHz, 64-QAM)	LTE-TDD	10.25	±9.6
10231	CAE	LTE-TDD (SC-FDMA, 1 RB, 3 MHz, QPSK)	LTE-TDD	9.19	±9.6
10232	CAH	LTE-TDD (SC-FDMA, 1 RB, 5 MHz, 16-QAM)	LTE-TDD	9.48	±9.6
10233	CAH	LTE-TDD (SC-FDMA, 1 RB, 5 MHz, 64-QAM)	LTE-TDD	10.25	±9.6
10234	CAH	LTE-TDD (SC-FDMA, 1 RB, 5 MHz, QPSK)	LTE-TDD	9.21	±9.6
10235	CAH	LTE-TDD (SC-FDMA, 1 RB, 10 MHz, 16-QAM)	LTE-TDD	9.48	±9.6
10236	CAH	LTE-TDD (SC-FDMA, 1 RB, 10 MHz, 64-QAM)	LTE-TDD	10.25	±9.6
10237	CAH	LTE-TDD (SC-FDMA, 1 RB, 10 MHz, QPSK)	LTE-TDD	9.21	±9.6
10238	CAG	LTE-TDD (SC-FDMA, 1 RB, 15 MHz, 16-QAM)	LTE-TDD	9.48	±9.6
10239	CAG	LTE-TDD (SC-FDMA, 1 RB, 15 MHz, 64-QAM)	LTE-TDD	10.25	±9.6
10240	CAG	LTE-TDD (SC-FDMA, 1 RB, 15 MHz, QPSK)	LTE-TDD	9.21	±9.6
10241	CAC	LTE-TDD (SC-FDMA, 50% RB, 1.4 MHz, 16-QAM)	LTE-TDD	9.82	±9.6
10242	CAC	LTE-TDD (SC-FDMA, 50% RB, 1.4 MHz, 64-QAM)	LTE-TDD	9.86	±9.6
10243	CAC	LTE-TDD (SC-FDMA, 50% RB, 1.4 MHz, QPSK)	LTE-TDD	9.46	±9.6
10244	CAE	LTE-TDD (SC-FDMA, 50% RB, 3 MHz, 16-QAM)	LTE-TDD	10.06	±9.6
10245	CAE	LTE-TDD (SC-FDMA, 50% RB, 3 MHz, 64-QAM)	LTE-TDD	10.06	±9.6
10246	CAE	LTE-TDD (SC-FDMA, 50% RB, 3 MHz, QPSK)	LTE-TDD	9.30	±9.6
10247	CAH	LTE-TDD (SC-FDMA, 50% RB, 5 MHz, 16-QAM)	LTE-TDD	9.91	±9.6
10248	CAH	LTE-TDD (SC-FDMA, 50% RB, 5 MHz, 64-QAM)	LTE-TDD	10.09	±9.6
10249	CAH	LTE-TDD (SC-FDMA, 50% RB, 5 MHz, QPSK)	LTE-TDD	9.29	±9.6
10250	CAH	LTE-TDD (SC-FDMA, 50% RB, 10 MHz, 16-QAM)	LTE-TDD	9.81	±9.6
10251	CAH	LTE-TDD (SC-FDMA, 50% RB, 10 MHz, 64-QAM)	LTE-TDD	10.17	±9.6
10252	CAH	LTE-TDD (SC-FDMA, 50% RB, 10 MHz, QPSK)	LTE-TDD	9.24	±9.6
10253	CAG	LTE-TDD (SC-FDMA, 50% RB, 15 MHz, 16-QAM)	LTE-TDD	9.90	±9.6
10254	CAG	LTE-TDD (SC-FDMA, 50% RB, 15 MHz, 64-QAM)	LTE-TDD	10.14	±9.6
10255	CAG	LTE-TDD (SC-FDMA, 50% RB, 15 MHz, QPSK)	LTE-TDD	9.20	±9.6
10256	CAC	LTE-TDD (SC-FDMA, 100% RB, 1.4 MHz, 16-QAM)	LTE-TDD	9.96	±9.6
10257	CAC	LTE-TDD (SC-FDMA, 100% RB, 1.4 MHz, 64-QAM)	LTE-TDD	10.08	±9.6
10258	CAC	LTE-TDD (SC-FDMA, 100% RB, 1.4 MHz, QPSK)	LTE-TDD	9.34	±9.6
10259	CAE	LTE-TDD (SC-FDMA, 100% RB, 3 MHz, 16-QAM)	LTE-TDD	9.98	±9.6
10260	CAE	LTE-TDD (SC-FDMA, 100% RB, 3 MHz, 64-QAM)	LTE-TDD	9.97	±9.6
10261	CAE	LTE-TDD (SC-FDMA, 100% RB, 3 MHz, QPSK)	LTE-TDD	9.24	±9.6
10262	CAH	LTE-TDD (SC-FDMA, 100% RB, 5 MHz, 16-QAM)	LTE-TDD	9.83	±9.6
10263	CAH	LTE-TDD (SC-FDMA, 100% RB, 5 MHz, 64-QAM)	LTE-TDD	10.16	±9.6
10264	CAH	LTE-TDD (SC-FDMA, 100% RB, 5 MHz, QPSK)	LTE-TDD	9.23	±9.6
10265	CAH	LTE-TDD (SC-FDMA, 100% RB, 10 MHz, 16-QAM)	LTE-TDD	9.92	±9.6
10266	CAH	LTE-TDD (SC-FDMA, 100% RB, 10 MHz, 64-QAM)	LTE-TDD	10.07	±9.6
10267	CAH	LTE-TDD (SC-FDMA, 100% RB, 10 MHz, QPSK)	LTE-TDD	9.30	±9.6
10268	CAG	LTE-TDD (SC-FDMA, 100% RB, 15 MHz, 16-QAM)	LTE-TDD	10.06	±9.6
10269	CAG	LTE-TDD (SC-FDMA, 100% RB, 15 MHz, 64-QAM)	LTE-TDD	10.13	±9.6
10270	CAG	LTE-TDD (SC-FDMA, 100% RB, 15 MHz, QPSK)	LTE-TDD	9.58	±9.6
10274	CAC	UMTS-FDD (HSUPA, Subtest 5, 3GPP Rel8.10)	WCDMA	4.87	±9.6
10275	CAC	UMTS-FDD (HSUPA, Subtest 5, 3GPP Rel8.4)	WCDMA	3.96	±9.6
10277	CAA	PHS (QPSK)	PHS	11.81	±9.6
10278	CAA	PHS (QPSK, BW 884 MHz, Rolloff 0.5)	PHS	11.81	±9.6
10279	CAA	PHS (QPSK, BW 884 MHz, Rolloff 0.38)	PHS	12.18	±9.6
10290	AAB	CDMA2000, RC1, SO55, Full Rate	CDMA2000	3.91	±9.6
10291	AAB	CDMA2000, RC3, SO55, Full Rate	CDMA2000	3.46	±9.6
10292	AAB	CDMA2000, RC3, SO32, Full Rate	CDMA2000	3.39	±9.6
10293	AAB	CDMA2000, RC3, SO3, Full Rate	CDMA2000	3.50	±9.6
10295	AAB	CDMA2000, RC1, SO3, 1/8th Rate 25 fr.	CDMA2000	12.49	±9.6
10297	AAE	LTE-FDD (SC-FDMA, 50% RB, 20 MHz, QPSK)	LTE-FDD	5.81	±9.6
10298	AAE	LTE-FDD (SC-FDMA, 50% RB, 3 MHz, QPSK)	LTE-FDD	5.72	±9.6
10299	AAE	LTE-FDD (SC-FDMA, 50% RB, 3 MHz, 16-QAM)	LTE-FDD	6.39	±9.6
10300	AAE	LTE-FDD (SC-FDMA, 50% RB, 3 MHz, 64-QAM)	LTE-FDD	6.60	±9.6
10301	AAA	IEEE 802.16e WiMAX (29:18, 5 ms, 10 MHz, QPSK, PUSC)	WiMAX	12.03	±9.6
10302	AAA	IEEE 802.16e WiMAX (29:18, 5 ms, 10 MHz, QPSK, PUSC, 3 CTRL symbols)	WiMAX	12.57	±9.6
10303	AAA	IEEE 802.16e WiMAX (31:15, 5 ms, 10 MHz, 64QAM, PUSC)	WiMAX	12.52	±9.6
10304	AAA	IEEE 802.16e WiMAX (29:18, 5 ms, 10 MHz, 64QAM, PUSC)	WiMAX	11.86	±9.6
10305	AAA	IEEE 802.16e WiMAX (31:15, 10 ms, 10 MHz, 64QAM, PUSC, 15 symbols)	WiMAX	15.24	±9.6
10306	AAA	IEEE 802.16e WiMAX (29:18, 10 ms, 10 MHz, 64QAM, PUSC, 18 symbols)	WiMAX	14.67	±9.6

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10307	AAA	IEEE 802.16e WiMAX (29:18, 10 ms, 10 MHz, QPSK, PUSC, 18 symbols)	WiMAX	14.49	±9.6
10308	AAA	IEEE 802.16e WiMAX (29:18, 10 ms, 10 MHz, 16QAM, PUSC)	WiMAX	14.46	±9.6
10309	AAA	IEEE 802.16e WiMAX (29:18, 10 ms, 10 MHz, 16QAM, AMC 2x3, 18 symbols)	WiMAX	14.58	±9.6
10310	AAA	IEEE 802.16e WiMAX (29:18, 10 ms, 10 MHz, QPSK, AMC 2x3, 18 symbols)	WiMAX	14.57	±9.6
10311	AAE	LTE-FDD (SC-FDMA, 100% RB, 15 MHz, QPSK)	LTE-FDD	6.06	±9.6
10313	AAA	iDEN 1:3	iDEN	10.51	±9.6
10314	AAA	iDEN 1:6	iDEN	13.48	±9.6
10315	AAB	IEEE 802.11b WiFi 2.4 GHz (DSSS, 1 Mbps, 96pc duty cycle)	WLAN	1.71	±9.6
10316	AAB	IEEE 802.11g WiFi 2.4 GHz (ERP-OFDM, 6 Mbps, 96pc duty cycle)	WLAN	8.36	±9.6
10317	AAE	IEEE 802.11a WiFi 5 GHz (OFDM, 6 Mbps, 96pc duty cycle)	WLAN	8.36	±9.6
10352	AAA	Pulse Waveform (200Hz, 10%)	Generic	10.00	±9.6
10353	AAA	Pulse Waveform (200Hz, 20%)	Generic	6.99	±9.6
10354	AAA	Pulse Waveform (200Hz, 40%)	Generic	3.98	±9.6
10355	AAA	Pulse Waveform (200Hz, 60%)	Generic	2.22	±9.6
10356	AAA	Pulse Waveform (200Hz, 80%)	Generic	0.97	±9.6
10387	AAA	QPSK Waveform, 1 MHz	Generic	5.10	±9.6
10388	AAA	QPSK Waveform, 10 MHz	Generic	5.22	±9.6
10396	AAA	64-QAM Waveform, 100 kHz	Generic	6.27	±9.6
10399	AAA	64-QAM Waveform, 40 MHz	Generic	6.27	±9.6
10400	AAF	IEEE 802.11ac WiFi (20 MHz, 64-QAM, 99pc duty cycle)	WLAN	8.37	±9.6
10401	AAF	IEEE 802.11ac WiFi (40 MHz, 64-QAM, 99pc duty cycle)	WLAN	8.60	±9.6
10402	AAF	IEEE 802.11ac WiFi (80 MHz, 64-QAM, 99pc duty cycle)	WLAN	8.53	±9.6
10403	AAB	CDMA2000 (1xEV-DO, Rev. 0)	CDMA2000	3.76	±9.6
10404	AAB	CDMA2000 (1xEV-DO, Rev. A)	CDMA2000	3.77	±9.6
10406	AAB	CDMA2000, RC3, SQ32, SCH0, Full Rate	CDMA2000	5.22	±9.6
10410	AAH	LTE-TDD (SC-FDMA, 1 RB, 10 MHz, QPSK, UL Subframe=2,3,4,7,8,9, Subframe Conf=4)	LTE-TDD	7.82	±9.6
10414	AAA	WLAN CCDF, 64-QAM, 40 MHz	Generic	8.54	±9.6
10415	AAA	IEEE 802.11b WiFi 2.4 GHz (DSSS, 1 Mbps, 99pc duty cycle)	WLAN	1.54	±9.6
10416	AAA	IEEE 802.11g WiFi 2.4 GHz (ERP-OFDM, 6 Mbps, 99pc duty cycle)	WLAN	8.23	±9.6
10417	AAD	IEEE 802.11a/h WiFi 5 GHz (OFDM, 6 Mbps, 99pc duty cycle)	WLAN	8.23	±9.6
10418	AAA	IEEE 802.11g WiFi 2.4 GHz (DSSS-OFDM, 6 Mbps, 99pc duty cycle, Long preamble)	WLAN	8.14	±9.6
10419	AAA	IEEE 802.11g WiFi 2.4 GHz (DSSS-OFDM, 6 Mbps, 99pc duty cycle, Short preamble)	WLAN	8.19	±9.6
10422	AAD	IEEE 802.11n (HT Greenfield, 7.2 Mbps, BPSK)	WLAN	8.32	±9.6
10423	AAD	IEEE 802.11n (HT Greenfield, 43.3 Mbps, 16-QAM)	WLAN	8.47	±9.6
10424	AAD	IEEE 802.11n (HT Greenfield, 72.2 Mbps, 64-QAM)	WLAN	8.40	±9.6
10425	AAD	IEEE 802.11n (HT Greenfield, 15 Mbps, BPSK)	WLAN	8.41	±9.6
10426	AAD	IEEE 802.11n (HT Greenfield, 90 Mbps, 16-QAM)	WLAN	8.45	±9.6
10427	AAD	IEEE 802.11n (HT Greenfield, 150 Mbps, 64-QAM)	WLAN	8.41	±9.6
10430	AAE	LTE-FDD (OFDMA, 5 MHz, E-TM 3.1)	LTE-FDD	8.28	±9.6
10431	AAE	LTE-FDD (OFDMA, 10 MHz, E-TM 3.1)	LTE-FDD	8.38	±9.6
10432	AAD	LTE-FDD (OFDMA, 15 MHz, E-TM 3.1)	LTE-FDD	8.34	±9.6
10433	AAD	LTE-FDD (OFDMA, 20 MHz, E-TM 3.1)	LTE-FDD	8.34	±9.6
10434	AAB	W-CDMA (BS Test Model 1, 64 DPCH)	WCDMA	8.60	±9.6
10435	AAG	LTE-TDD (SC-FDMA, 1 RB, 20 MHz, QPSK, UL Subframe=2,3,4,7,8,9)	LTE-TDD	7.82	±9.6
10447	AAE	LTE-FDD (OFDMA, 5 MHz, E-TM 3.1, Clipping 44%)	LTE-FDD	7.56	±9.6
10448	AAE	LTE-FDD (OFDMA, 10 MHz, E-TM 3.1, Clipping 44%)	LTE-FDD	7.53	±9.6
10449	AAD	LTE-FDD (OFDMA, 15 MHz, E-TM 3.1, Clipping 44%)	LTE-FDD	7.51	±9.6
10450	AAD	LTE-FDD (OFDMA, 20 MHz, E-TM 3.1, Clipping 44%)	LTE-FDD	7.48	±9.6
10451	AAB	W-CDMA (BS Test Model 1, 64 DPCH, Clipping 44%)	WCDMA	7.59	±9.6
10453	AAE	Validation (Square, 10 ms, 1 ms)	Test	10.00	±9.6
10456	AAD	IEEE 802.11ac WiFi (160 MHz, 64-QAM, 99pc duty cycle)	WLAN	8.63	±9.6
10457	AAB	UMTS-FDD (DC-HSDPA)	WCDMA	6.62	±9.6
10458	AAA	CDMA2000 (1xEV-DO, Rev. B, 2 carriers)	CDMA2000	6.55	±9.6
10459	AAA	CDMA2000 (1xEV-DO, Rev. B, 3 carriers)	CDMA2000	8.25	±9.6
10460	AAB	UMTS-FDD (WCDMA, AMR)	WCDMA	2.39	±9.6
10461	AAC	LTE-TDD (SC-FDMA, 1 RB, 1.4 MHz, QPSK, UL Subframe=2,3,4,7,8,9)	LTE-TDD	7.82	±9.6
10462	AAC	LTE-TDD (SC-FDMA, 1 RB, 1.4 MHz, 16-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.30	±9.6
10463	AAC	LTE-TDD (SC-FDMA, 1 RB, 1.4 MHz, 64-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.56	±9.6
10464	AAD	LTE-TDD (SC-FDMA, 1 RB, 3 MHz, QPSK, UL Subframe=2,3,4,7,8,9)	LTE-TDD	7.82	±9.6
10465	AAD	LTE-TDD (SC-FDMA, 1 RB, 3 MHz, 16-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.32	±9.6
10466	AAD	LTE-TDD (SC-FDMA, 1 RB, 3 MHz, 64-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.57	±9.6
10467	AAG	LTE-TDD (SC-FDMA, 1 RB, 5 MHz, QPSK, UL Subframe=2,3,4,7,8,9)	LTE-TDD	7.82	±9.6
10468	AAG	LTE-TDD (SC-FDMA, 1 RB, 5 MHz, 16-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.32	±9.6
10469	AAG	LTE-TDD (SC-FDMA, 1 RB, 5 MHz, 64-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.56	±9.6
10470	AAG	LTE-TDD (SC-FDMA, 1 RB, 10 MHz, QPSK, UL Subframe=2,3,4,7,8,9)	LTE-TDD	7.82	±9.6
10471	AAG	LTE-TDD (SC-FDMA, 1 RB, 10 MHz, 16-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.32	±9.6

UID	Rev	Communication System Name	Group	PAR (dB)	Unc ^E k = 2
10472	AAG	LTE-TDD (SC-FDMA, 1 RB, 10 MHz, 64-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.57	±9.6
10473	AAF	LTE-TDD (SC-FDMA, 1 RB, 15 MHz, QPSK, UL Subframe=2,3,4,7,8,9)	LTE-TDD	7.82	±9.6
10474	AAF	LTE-TDD (SC-FDMA, 1 RB, 15 MHz, 16-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.32	±9.6
10475	AAF	LTE-TDD (SC-FDMA, 1 RB, 15 MHz, 64-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.57	±9.6
10477	AAG	LTE-TDD (SC-FDMA, 1 RB, 20 MHz, 16-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.32	±9.6
10478	AAG	LTE-TDD (SC-FDMA, 1 RB, 20 MHz, 64-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.57	±9.6
10479	AAC	LTE-TDD (SC-FDMA, 50% RB, 1.4 MHz, QPSK, UL Subframe=2,3,4,7,8,9)	LTE-TDD	7.74	±9.6
10480	AAC	LTE-TDD (SC-FDMA, 50% RB, 1.4 MHz, 16-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.18	±9.6
10481	AAC	LTE-TDD (SC-FDMA, 50% RB, 1.4 MHz, 64-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.45	±9.6
10482	AAD	LTE-TDD (SC-FDMA, 50% RB, 3 MHz, QPSK, UL Subframe=2,3,4,7,8,9)	LTE-TDD	7.71	±9.6
10483	AAD	LTE-TDD (SC-FDMA, 50% RB, 3 MHz, 16-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.39	±9.6
10484	AAD	LTE-TDD (SC-FDMA, 50% RB, 3 MHz, 64-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.47	±9.6
10485	AAG	LTE-TDD (SC-FDMA, 50% RB, 5 MHz, QPSK, UL Subframe=2,3,4,7,8,9)	LTE-TDD	7.59	±9.6
10486	AAG	LTE-TDD (SC-FDMA, 50% RB, 5 MHz, 16-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.38	±9.6
10487	AAG	LTE-TDD (SC-FDMA, 50% RB, 5 MHz, 64-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.60	±9.6
10488	AAG	LTE-TDD (SC-FDMA, 50% RB, 10 MHz, QPSK, UL Subframe=2,3,4,7,8,9)	LTE-TDD	7.70	±9.6
10489	AAG	LTE-TDD (SC-FDMA, 50% RB, 10 MHz, 16-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.31	±9.6
10490	AAG	LTE-TDD (SC-FDMA, 50% RB, 10 MHz, 64-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.54	±9.6
10491	AAF	LTE-TDD (SC-FDMA, 50% RB, 15 MHz, QPSK, UL Subframe=2,3,4,7,8,9)	LTE-TDD	7.74	±9.6
10492	AAF	LTE-TDD (SC-FDMA, 50% RB, 15 MHz, 16-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.41	±9.6
10493	AAF	LTE-TDD (SC-FDMA, 50% RB, 15 MHz, 64-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.55	±9.6
10494	AAG	LTE-TDD (SC-FDMA, 50% RB, 20 MHz, QPSK, UL Subframe=2,3,4,7,8,9)	LTE-TDD	7.74	±9.6
10495	AAG	LTE-TDD (SC-FDMA, 50% RB, 20 MHz, 16-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.37	±9.6
10496	AAG	LTE-TDD (SC-FDMA, 50% RB, 20 MHz, 64-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.54	±9.6
10497	AAC	LTE-TDD (SC-FDMA, 100% RB, 1.4 MHz, QPSK, UL Subframe=2,3,4,7,8,9)	LTE-TDD	7.67	±9.6
10498	AAC	LTE-TDD (SC-FDMA, 100% RB, 1.4 MHz, 16-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.40	±9.6
10499	AAC	LTE-TDD (SC-FDMA, 100% RB, 1.4 MHz, 64-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.68	±9.6
10500	AAD	LTE-TDD (SC-FDMA, 100% RB, 3 MHz, QPSK, UL Subframe=2,3,4,7,8,9)	LTE-TDD	7.67	±9.6
10501	AAD	LTE-TDD (SC-FDMA, 100% RB, 3 MHz, 16-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.44	±9.6
10502	AAD	LTE-TDD (SC-FDMA, 100% RB, 3 MHz, 64-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.52	±9.6
10503	AAG	LTE-TDD (SC-FDMA, 100% RB, 5 MHz, QPSK, UL Subframe=2,3,4,7,8,9)	LTE-TDD	7.72	±9.6
10504	AAG	LTE-TDD (SC-FDMA, 100% RB, 5 MHz, 16-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.31	±9.6
10505	AAG	LTE-TDD (SC-FDMA, 100% RB, 5 MHz, 64-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.54	±9.6
10506	AAG	LTE-TDD (SC-FDMA, 100% RB, 10 MHz, QPSK, UL Subframe=2,3,4,7,8,9)	LTE-TDD	7.74	±9.6
10507	AAG	LTE-TDD (SC-FDMA, 100% RB, 10 MHz, 16-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.36	±9.6
10508	AAG	LTE-TDD (SC-FDMA, 100% RB, 10 MHz, 64-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.55	±9.6
10509	AAF	LTE-TDD (SC-FDMA, 100% RB, 15 MHz, QPSK, UL Subframe=2,3,4,7,8,9)	LTE-TDD	7.99	±9.6
10510	AAF	LTE-TDD (SC-FDMA, 100% RB, 15 MHz, 16-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.49	±9.6
10511	AAF	LTE-TDD (SC-FDMA, 100% RB, 15 MHz, 64-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.51	±9.6
10512	AAG	LTE-TDD (SC-FDMA, 100% RB, 20 MHz, QPSK, UL Subframe=2,3,4,7,8,9)	LTE-TDD	7.74	±9.6
10513	AAG	LTE-TDD (SC-FDMA, 100% RB, 20 MHz, 16-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.42	±9.6
10514	AAG	LTE-TDD (SC-FDMA, 100% RB, 20 MHz, 64-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.45	±9.6
10515	AAA	IEEE 802.11b WiFi 2.4 GHz (DSSS, 2 Mbps, 99pc duty cycle)	WLAN	1.58	±9.6
10516	AAA	IEEE 802.11b WiFi 2.4 GHz (DSSS, 5.5 Mbps, 99pc duty cycle)	WLAN	1.57	±9.6
10517	AAA	IEEE 802.11b WiFi 2.4 GHz (DSSS, 11 Mbps, 99pc duty cycle)	WLAN	1.58	±9.6
10518	AAD	IEEE 802.11a/h WiFi 5 GHz (OFDM, 9 Mbps, 99pc duty cycle)	WLAN	8.23	±9.6
10519	AAD	IEEE 802.11a/h WiFi 5 GHz (OFDM, 12 Mbps, 99pc duty cycle)	WLAN	8.39	±9.6
10520	AAD	IEEE 802.11a/h WiFi 5 GHz (OFDM, 18 Mbps, 99pc duty cycle)	WLAN	8.12	±9.6
10521	AAD	IEEE 802.11a/h WiFi 5 GHz (OFDM, 24 Mbps, 99pc duty cycle)	WLAN	7.97	±9.6
10522	AAD	IEEE 802.11a/h WiFi 5 GHz (OFDM, 36 Mbps, 99pc duty cycle)	WLAN	8.45	±9.6
10523	AAD	IEEE 802.11a/h WiFi 5 GHz (OFDM, 48 Mbps, 99pc duty cycle)	WLAN	8.08	±9.6
10524	AAD	IEEE 802.11a/h WiFi 5 GHz (OFDM, 54 Mbps, 99pc duty cycle)	WLAN	8.27	±9.6
10525	AAD	IEEE 802.11ac WiFi (20 MHz, MCS0, 99pc duty cycle)	WLAN	8.36	±9.6
10526	AAD	IEEE 802.11ac WiFi (20 MHz, MCS1, 99pc duty cycle)	WLAN	8.42	±9.6
10527	AAD	IEEE 802.11ac WiFi (20 MHz, MCS2, 99pc duty cycle)	WLAN	8.21	±9.6
10528	AAD	IEEE 802.11ac WiFi (20 MHz, MCS3, 99pc duty cycle)	WLAN	8.36	±9.6
10529	AAD	IEEE 802.11ac WiFi (20 MHz, MCS4, 99pc duty cycle)	WLAN	8.36	±9.6
10531	AAD	IEEE 802.11ac WiFi (20 MHz, MCS6, 99pc duty cycle)	WLAN	8.43	±9.6
10532	AAD	IEEE 802.11ac WiFi (20 MHz, MCS7, 99pc duty cycle)	WLAN	8.29	±9.6
10533	AAD	IEEE 802.11ac WiFi (20 MHz, MCS8, 99pc duty cycle)	WLAN	8.38	±9.6
10534	AAD	IEEE 802.11ac WiFi (40 MHz, MCS0, 99pc duty cycle)	WLAN	8.45	±9.6
10535	AAD	IEEE 802.11ac WiFi (40 MHz, MCS1, 99pc duty cycle)	WLAN	8.45	±9.6
10536	AAD	IEEE 802.11ac WiFi (40 MHz, MCS2, 99pc duty cycle)	WLAN	8.32	±9.6
10537	AAD	IEEE 802.11ac WiFi (40 MHz, MCS3, 99pc duty cycle)	WLAN	8.44	±9.6
10538	AAD	IEEE 802.11ac WiFi (40 MHz, MCS4, 99pc duty cycle)	WLAN	8.54	±9.6
10540	AAD	IEEE 802.11ac WiFi (40 MHz, MCS6, 99pc duty cycle)	WLAN	8.39	±9.6